Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/943,246	HUYNH, DUANE Q.
Examiner	Art Unit
Tianjie Chen	2652

SEARCHED					
Class	Subclass	Date	Examiner		
360	265.9	3/13/2005	ΤJ		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
265.9	5/13/2005	TJ			
	Subclass	Subclass Date			

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	DATE	EXMR
East Report	3/15/2005	TJ